

IGBT Chip in NPT-technology

FEATURES:

- 1200V NPT technology 175µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- · easy paralleling
- integrated gate resistor

This chip is used for:

• IGBT Modules



Applications:

• drives, SMPS, resonant applications

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC121T120R2CS	1200V	75A	11.08 X 11.08 mm ²	sawn on foil	Q67050- A4074-A003

MECHANICAL PARAMETER:

Raster size	11.08 X 11.08	mm ²		
Emitter pad size	8 x (2.99 x 1.97)			
Gate pad size	1.46 x 0.8			
Area total / active	122.8 / 99.6			
Thickness	180	μm		
Wafer size	150	mm		
Flat position	90	grd		
Max.possible chips per wafer	106 pcs			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm Al Si 1%			
Collector metallization 1400 nm Ni Ag —system suitable for epoxy and soft solder die b				
Die bond	electrically conductive glue or solder			
Wire bond	AI, <500μm			
Reject Ink Dot Size	Ø 0.65mm ; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	1)	Α
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	225	Α
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_i =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
i arameter	Symbol	Conditions	min.	typ.	max.	O.IIIC
Collector-emitter breakdown voltage	V _{(BR)CES}	V _{GE} =0V , I _C =4mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =75A	2.7	3.2	3.7	V
Gate-emitter threshold voltage	V _{GE(th)}	$I_C=3mA$, $V_{GE}=V_{CE}$	4.5	5.5	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V , V _{GE} =0V			10	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V , V _{GE} =20V			480	nA
Integrated gate resistor	R _{Gint}			5	7	Ω

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol Conditions	Value			Unit	
raiametei	Symbol	Conditions	min.	typ.	max.	Onne
Input capacitance	Ciss	V _{CE} =25V,		5.1		nF
Output capacitance	Coss	$V_{GE}=0V$,		0.72		
Reverse transfer capacitance	Crss	f=1MHz		0.38		

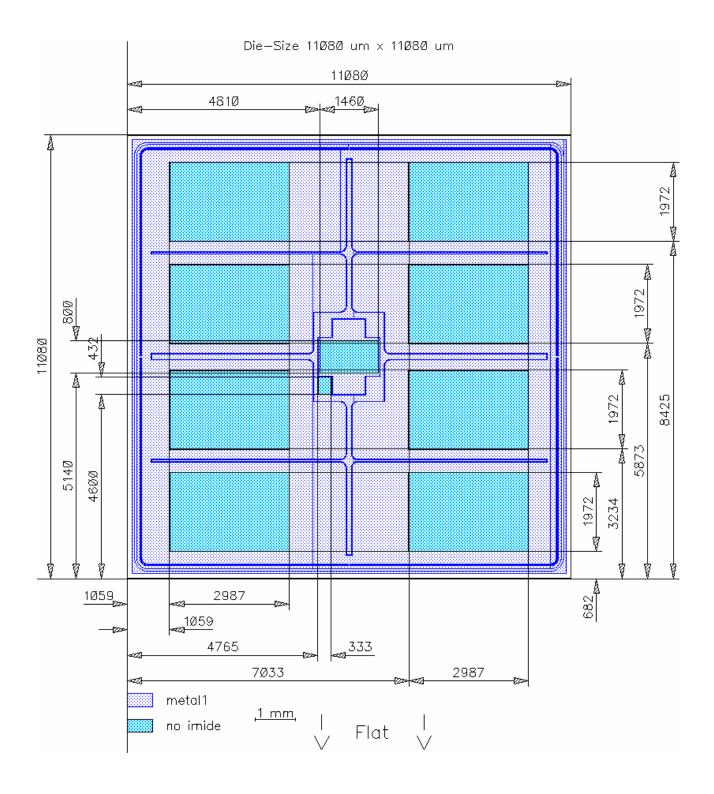
SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions 1)	Value			Unit
r ai ailletei	Symbol		min.	typ.	max.	Oilit
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =125°C		0.13		μs
Rise time	t_{r}	$V_{\rm CC} = 600 \text{V},$		0.06		
Turn-off delay time	$t_{d(off)}$	I _C =75A, V _{GE} =-15/15V,		0.36		
Fall time	t_{f}	$R_{\rm G}$ =7.5 Ω		0.03		

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	Eupec	FS75R12KS4					
DESCRIPTION:							
AQL 0,65 for visual inspection according to failure catalog							
Electrostatic Discharge Sensitive Device according to MIL-STD 883							
Test-Normen Villach/Prüffeld							

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